

<b>Notice of References Cited</b>	Application/Control No. 10/521,942		Applicant(s)/Patent Under Reexamination HIKAWA ET AL.	
	Examiner Manuel L. Barbee		Art Unit 2857	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,596,123 A	06-1986	Cooperman, Curtis L.	62/199
*	B	US-4,616,179 A	10-1986	Braun, Dennis H.	324/772
*	C	US-5,056,032 A	10-1991	Swanson et al.	700/292
*	D	US-5,512,883 A	04-1996	Lane, Jr., William E.	340/648
*	E	US-5,712,551 A	01-1998	Lee, Kun-bin	318/466
*	F	US-5,754,450 A	05-1998	Solomon et al.	702/35
*	G	US-6,283,631 B1	09-2001	Gousset et al.	374/152
*	H	US-2002/0170305 A1	11-2002	Nakajima, Seichi	62/228.4
*	I	US-2003/0001536 A1	01-2003	Kitajima, Yasuhiko	318/629
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 2001-138966	05-2002	Japan	Toshiyuki Maeda et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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